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Ac losses in field-cooled type I superconducting cavities

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Abstract

As superconductors are cooled below their critical temperature, stray magnetic flux can become trapped in regions that remain normal. The presence of trapped flux facilitates dissipation of ac current in a superconductor, leading to losses in superconducting elements of microwave devices. In type II superconductors, dissipation is well-understood in terms of the dynamics of vortices hosting a single flux quantum. In contrast, the ac response of type I superconductors with trapped flux has not received much attention. Building on Andreev's early work (Andreev 1967 *Sov. Phys. JETP* **24** 1019), here we show theoretically that the dominant dissipation mechanism is the absorption of the ac field at the exposed surfaces of the normal regions, while the deformation of the superconducting/normal interfaces is unimportant. We use the developed theory to estimate the degradation of the quality factors in field-cooled cavities, and we satisfactorily compare these theoretical estimates to the measured field dependence of the quality factors of two aluminum cavities. We also identify a regime in which the dissipated power depends weakly on the Ginzburg-Landau parameter; this makes it possible to apply our findings to cavities made of other materials, such as niobium.

Keywords: cavities, Ac losses, type I, flux flow

(Some figures may appear in colour only in the online journal)

1. Introduction

Superconducting cavities are under intense investigation for diverse applications such as particle accelerators [1] and quantum information processing [2]. A fundamental question

of practical importance is what limits their quality factors, or equivalently what mechanisms are responsible for power dissipation. In type II superconductors, it has long been recognized that one such mechanism is the motion of vortices, also known as flux flow. Vortices are present when a superconductor is cooled in a magnetic field B_0 exceeding the lower critical field B_{c1} . For high-field applications, such as superconducting magnets and RF cavities for particle accelerators, the flux-flow dissipation can significantly impact performance. By pinning vortices, the dissipation can be reduced, and this has led to intense and still ongoing research into ways to pin vortices, both for dc [3] and ac [4, 5] applications, and into surface treatments [6] to remove defects facilitating vortex penetration into the bulk of superconducting cavities [7].

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In the case of superconducting devices for quantum information processing the ac fields involved are usually weak, and external magnetic fields are carefully screened. The most widely used material for superconducting quantum devices—including bulk cavities—is aluminum, which is a type I superconductor. When cooled in a field, type I superconductors can enter into the so-called intermediate state, in which normal-state regions are interspersed among superconducting ones, allowing the passage of magnetic flux. These normal regions can take different shapes, such as flux tubes, resembling vortices, or laminar domains; a number of theoretical and experimental studies have focused on this aspect of the intermediate state over the years [8–10], and on dc losses [11, 12]. Surprisingly little attention has been given to the question of ac losses in the intermediate state associated with these normal regions, with the notable exception of the seminal works by Andreev and collaborators [13–15]. Here we revisit this issue to give a unified picture of ac dissipation in superconductors (valid for both type I and type II in an appropriate regime), and to compare the theory to the results of experiments performed with type I cavities.

In the next section we summarize Andreev’s result for dissipation in type I superconductors [13] and relate it to that in type II materials. In section 3 we first derive an estimate for the dependence of a superconducting cavity quality factor Q on cooling field, which is then compared to experiments with bulk aluminum cavities of two different geometries. We summarize and discuss our findings in section 4, where we also consider previous experiments with niobium cavities.

2. Ac dissipation in type I superconductors

In contrast to vortices in type II superconductors, whose normal-core radius is of the order of the coherence length ξ and much shorter than the magnetic field penetration depth λ , normal regions in type I superconductors can be of a macroscopic size. As already shown in the early work by Landau [8], for the laminar configuration the width w_n of the normal parts is of the order of $w_n \sim \sqrt{d\delta}$, with $\delta \approx \xi - \lambda$ and d the sample thickness (see for instance section 2.3.2 in [16]); for a strongly type I superconductor, with Ginzburg-Landau parameter $\kappa = \lambda/\xi \ll 1$, we have $\delta \sim \xi$, far exceeding λ . In the absence of pinning and at a relatively low frequency, this difference is inconsequential, as the normal regions in a type I superconductor can move. As was shown in [13], due to this motion there is flux-flow dissipation in the presence of a dc current, and the dc resistance in the intermediate state is proportional to the normal-state fraction $x_n = B_0/B_c$ of the sample ($B_c = \Phi_0/2\pi\xi\lambda$ is the thermodynamic critical field, with Φ_0 the magnetic flux quantum). This mechanism of the dc dissipation, which was later extended to flux tubes [15], is no different than the one at work in type II superconductors. Interestingly, at a sufficiently high frequency ω the ac dissipation in a type I superconductor does not involve motion of the normal regions, and is therefore unaffected by pinning (the similar regime for type II superconductors is discussed in appendix A). Once the electromagnetic normal-state skin depth becomes

shorter than w_n , the impinging field penetrates into the static normal domains thus producing the dissipation.

The surface resistance R_s is associated with the skin effect in the normal domains [13],

$$R_s = \sqrt{\frac{\mu_0\omega\rho_n}{2}} \frac{B_0}{B_c}, \quad (1)$$

where the square root factor is the normal-state surface resistance⁶, μ_0 is the vacuum permeability, ρ_n is the normal-state resistivity, and B_0/B_c is the normal fraction x_n in a thick ($d \gg \lambda$) superconducting plate cooled in a field perpendicular to its surface (the generalization to a tilted field can be found in [13]). The power dissipated per unit area \tilde{P}_1 for a type I superconductor is then

$$\tilde{P}_1 = \frac{1}{2} R_s H_p^2 = \frac{B_0}{B_c} \frac{H_p^2}{2} \sqrt{\frac{\mu_0\omega\rho_n}{2}}, \quad (2)$$

where H_p denotes the component of the ac magnetic field parallel to the surface. While the ac field does not lead to the overall motion of the normal regions, it can cause a deformation of the interface between the normal and superconducting regions. It was claimed [13] that this deformation does not significantly contribute to losses in type I superconductors; we show next that this is indeed the case. The result will enable us to interpolate between the dissipation in type I and type II superconductors.

2.1. Deformation of the normal/superconductor interface

Let us consider a planar domain wall separating a normal region from a superconducting one; in the intermediate state, the magnetic field is zero in the superconducting part and B_c in the normal one. The equation governing the displacement $u(z, t)$ of the wall has the same form as for vortices [17],

$$\tilde{\eta}\dot{u} = \tilde{\varepsilon}u'' + \tilde{F}e^{-z/\lambda}e^{-i\omega t}. \quad (3)$$

Here \dot{u} and u'' are, respectively, the time derivative and the second spatial derivative of the displacement, $\tilde{\eta}$ is the drag coefficient, $\tilde{\varepsilon}$ is the domain wall’s surface tension, and \tilde{F} is the Lorentz force (per unit area) at $z = 0$; this force acting on the domain wall is due to the ac field parallel to the superconductor’s surface. (The displacement u is in principle also a function of the other direction, x , along the wall, but since the force depends only on z , there is translational invariance along x .) The dissipated power P_w (per unit length along the wall) associated with the deformation of the domain wall, obtained by integrating over z the velocity time force product $\dot{u}\tilde{F}e^{-z/\lambda}$, is (see appendix A)

$$P_w = \frac{1}{2}(\lambda\tilde{F})^2 \sqrt{\frac{\omega}{2\tilde{\eta}\tilde{\varepsilon}}}. \quad (4)$$

Next we address the question of how to estimate the parameters in the right hand side of equation (4) for a type I superconductor.

⁶ Equation (1) assumes the most common case of the normal skin effect.

As with any domain wall separating two phases, there is a surface energy γ associated with the domain wall. In the present case the surface energy is (see also section 4.3 in [16])

$$\gamma = \delta \frac{B_c^2}{2\mu_0}, \quad (5)$$

with $\delta \approx \xi - \lambda$, as introduced at the beginning of this section. Therefore we estimate the surface tension for a domain wall in a type I superconductor as

$$\tilde{\varepsilon} = \xi \frac{B_c^2}{2\mu_0}. \quad (6)$$

For the drag coefficient $\tilde{\eta}$, we can reason in a way similar to that for vortices (section 5.5.1 in [16]), but adapting it to the domain wall. As for vortices, we attribute the drag to Joule heating in the normal part, and if the wall is moving with speed v_D in the direction normal to the wall, the dissipated power per area is then $\tilde{\eta}v_D^2$. Here the relevant normal part is the region of thickness ξ over which the order parameter is rising, while the magnetic field has already decreased significantly over the shorter length λ , see figure 1. Indeed, if we take an arbitrary contour fully contained in the normal region with magnetic field B_c , the flux through the enclosed area does not change in time, so there is no electric field in that region. On the other hand, by considering a rectangle with a side in the normal region with field B_c and the parallel side in the superconducting region (of thickness $\sim \xi$) with no field, by Maxwell equations the electric field E in the latter region has magnitude

$$E = B_c v_D. \quad (7)$$

According to Ohm's law, the dissipated power density is E^2/ρ_n . Integrating it over the thickness ξ of the normal region with electric field E of equation (7) and equating the result to $\tilde{\eta}v_D^2$, we arrive at the estimate

$$\tilde{\eta} = \xi \frac{B_c^2}{\rho_n}. \quad (8)$$

We estimate the force per unit area \tilde{F} acting on the domain wall by evaluating the difference between the energy density \mathcal{E} in the presence of a small external quasi-static field of magnitude $H_p \ll B_c/\mu_0$ and the energy density in its absence [see equation (6) in [13]]. The energy density is given by the kinetic energy density $\mu_0 \lambda^2 j^2/2$ of the current density j in the domain wall. Without the ac field, we have the field going from B_c to zero over distance λ (see figure 1); then by Maxwell equation, the magnitude of the screening current in that region is $j_s \approx B_c/\mu_0 \lambda$. Once the quasi-static ac field is applied, there is additional current $j_p \approx (H_p/\lambda)e^{-z/\lambda}e^{-i\omega t}$. Assuming that the ac field is perpendicular to the wall, the additional current is parallel to j_s , and the change in energy density is

$$\begin{aligned} \Delta \mathcal{E} &= \frac{1}{2} \mu_0 \lambda^2 [(j_s + j_p)^2 - j_s^2] \approx \mu_0 \lambda^2 j_s j_p \\ &\approx B_c H_p e^{-z/\lambda} e^{-i\omega t}. \end{aligned} \quad (9)$$

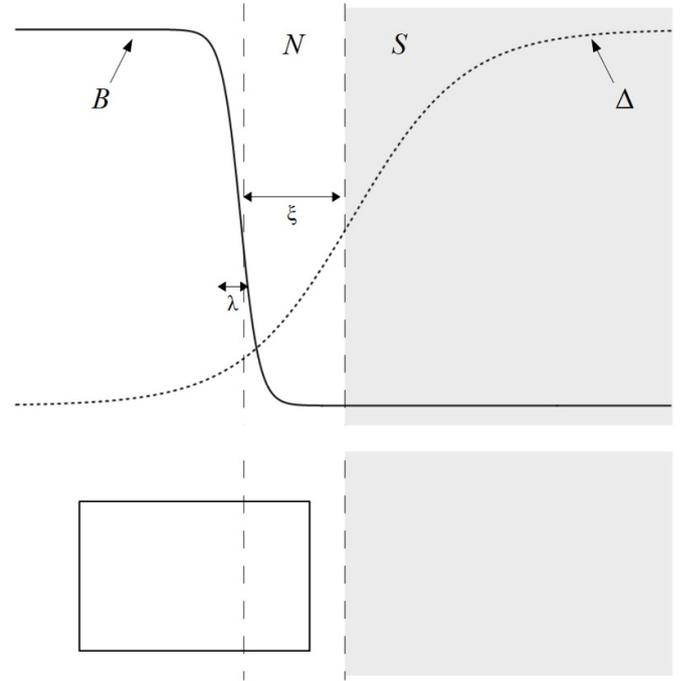


Figure 1. Top: schematic representation of a domain wall. From left to right, the magnetic field B (solid line) decreases from B_c to zero over the penetration depth λ , while the order parameter Δ (dotted line) rises from zero to a finite value over the much longer coherence length ξ . The superconducting region S is shaded, while the normal region N with finite electric field is comprised between the two vertical dashed lines. Bottom: the rectangular integration contour used to calculate the electric field, as viewed from above the surface of the superconductor. Contours fully to the left (right) of the left (right) dashed line give no electric field in the regions outside the two vertical lines.

Therefore the magnitude of the force acting on the domain wall is⁷

$$\tilde{F} = B_c H_p. \quad (10)$$

Note that if H_p has a component H_{pp} parallel to the wall, the added current is perpendicular to the wall, and its contribution to the energy density is smaller by a factor $\mu_0 H_{pp}/B_c \ll 1$, so we neglect its effect.

We have now all the ingredients needed to estimate the dissipated power per unit area associated with the deformation of the interfaces between normal and superconducting domains. For each superconducting domain, there are two such interfaces, and the number of domains per unit length (i.e. their linear density) can be written as $B_0/B_c w_n$, accounting for the ‘squeezing’ of the cooling field B_0 into regions of width w_n where the field reaches the critical value B_c (see section 2.3.3

⁷ A more accurate modeling of the forces acting on the domain wall should also take into consideration the Lorentz force due to the currents flowing in the N region. The corresponding current density is $\sim H_p/\delta_s$, where δ_s is the skin depth, see equation (20). However, at the frequencies under consideration ($\omega \ll \omega_\lambda$, see appendix A), we have $\delta_s \gg \lambda$, so it is consistent to neglect this contribution.

in [16]). Therefore, the dissipated power per unit area \tilde{P}_w originating from the domain walls is

$$\tilde{P}_w = 2P_w \frac{B_0}{B_c w_n} = \tilde{P}_I 2\kappa^2 \frac{\sqrt{2}\xi}{w_n}, \quad (11)$$

where we have substituted equations (6), (8) and (10) into equation (4) and used equation (2). For a type I superconductor, $2\kappa^2 < 1$ and if the laminae are macroscopic, $w_n \sim \sqrt{d\xi}$ with $d \gg \xi$ being the sample thickness, then $\xi/w_n \ll 1$. Therefore we expect that $\tilde{P}_w \ll \tilde{P}_I$: the power loss from deformation of the interfaces can be neglected, which confirms Andreev's assertion [13].

The above result holds also if the normal regions are flux tubes rather than laminae. In this case, the parameters entering equation (3) are per unit length rather than per unit area [see equation (A.2)] and can be approximately obtained by multiplying those in equations (6), (8) and (10) by πR_t , with R_t the tubes' radius (see also appendix B); this leads to a dissipated power $\pi R_t P_w$ per flux tube. Since the number of tubes per unit area is $B_0/B_c \pi R_t^2$, we find

$$\tilde{P}_t = \tilde{P}_I 2\kappa^2 \frac{\sqrt{2}\xi}{R_t} \quad (12)$$

for the dissipated power per unit area from the deformation of the interfaces of the tubes; this power \tilde{P}_t can again be neglected in comparison to \tilde{P}_I .

2.2. Dissipation as function of κ

The above findings enable us to estimate how the dissipated power in the presence of flux depend on the Ginzburg-Landau parameter κ . To this end, we compare the dissipation by flux tubes in type I superconductors to that by vortices in type II superconductors. Let us introduce the powers per unit area \tilde{P}_d arising from the deformation of the normal/superconductor interface and \tilde{P}_s due to direct, local loss from the parts of the surface which are in the normal state. For type I superconductors they are given in equations (2) and (12), respectively. The corresponding expressions for type II superconductors can be found in appendix A [equations (A.9) and (A.10)]. We can summarize the results in the form

$$\frac{\tilde{P}_d}{\tilde{P}_I} \approx \begin{cases} 2\kappa^2 \sqrt{2}\xi/R_t, & \kappa \ll 1 \\ \sqrt{2/\ln \kappa}, & \kappa \gg 1 \end{cases} \quad (13)$$

and

$$\frac{\tilde{P}_s}{\tilde{P}_I} \approx \begin{cases} 1, & \kappa \ll 1 \\ 1/2\kappa, & \kappa \gg 1, \end{cases} \quad (14)$$

where formulas for $\kappa \ll 1$ apply at intermediate frequencies (above the depinning one and below the saturation one⁸, see appendix A for more details).

As discussed above, we have $\tilde{P}_s \gg \tilde{P}_d$ for $\kappa \ll 1$, while we find $\tilde{P}_s \ll \tilde{P}_d$ for $\kappa \gg 1$. Interestingly, at κ of order unity both mechanisms give contributions of similar order. In the case of the power \tilde{P}_d for flux tubes in the type I regime, this can be seen as follows: for small κ the tube radius is macroscopic, $R_t \sim \sqrt{d\delta} \approx \sqrt{d\xi}$ (we remind that d is the sample thickness and $\delta \approx \xi - \lambda$); as κ increases, the coherence length ξ and the penetration depth λ become of the same order, and therefore $\delta \rightarrow 0$. However, the coherence length is the minimum length over which the order parameter can vary, so we must always have $R_t \gtrsim \xi$, and the inequality will saturate for values of κ of order unity. In summary, for the total dissipated power per unit area $\tilde{P} = \tilde{P}_d + \tilde{P}_s$ we find a weak dependence on κ at intermediate frequencies, since we have shown that in this regime there is a smooth crossover from \tilde{P}_I at small κ to $\tilde{P}_{II} = \tilde{P}_I \sqrt{2/\ln \kappa}$ at large κ . The crossover is smooth despite the fact that the dominant dissipation mechanisms in the two limits are distinct: in type II superconductors the power is determined by the interplay between the elastic deformation of the vortex core and the ohmic loss in it, while in type I superconductors the power is given by the local loss within the surface layer of the normal-state regions exposed to the ac field (the surface layer thickness is given by the skin depth). In the next section we consider how this dissipated power affects the quality factor of a superconducting cavity.

3. Dependence of cavity quality factor on cooling field

The quality factor Q of a resonant systems is defined as the ratio between the energy U stored in the resonator over the energy loss per unit cycle P_{tot}/ω ,

$$Q = \frac{U\omega}{P_{\text{tot}}}, \quad (15)$$

where P_{tot} and ω are the total dissipated power and the angular frequency, respectively. As discussed in the Introduction, reaching a high quality factor is useful in many applications. Here we focus on the contribution P to the dissipated power originating from trapped flux, $P_{\text{tot}} = P_0 + P$, where P_0 denotes the power loss in the absence of trapped flux (due, for example, to dielectric losses, two-level systems, etc). We have seen in the previous sections that P is proportional to the cooling field B_0 ; therefore we can separate the inverse quality factor of a superconducting cavity into a zero-field part and a field-dependent part:

$$\frac{1}{Q} = \frac{1}{Q_0} + \frac{1}{Q(B_0)} \quad (16)$$

with

$$\frac{1}{Q(B_0)} = \frac{P}{\omega U} \equiv \alpha B_0. \quad (17)$$

Here we have introduced the coefficient α , which measures how the quality factor degrades as the cooling field increases. The dissipated power P is obtained by integrating the dissipated power per unit area \tilde{P} ; over those parts of

⁸ For niobium the saturation frequency is about 250 GHz [17], well above typical frequencies used in applications.

the internal cavity surface, denoted with S_f , where there is trapped flux passing through the surface; then surfaces parallel to the cooling field are in general excluded from the integral. Moreover, there has to be a finite parallel component $H_p(r)$ of the magnetic field at the active surfaces for the power to be non-zero. (See figure 2 for examples of surfaces S_f .) The stored energy U can be calculated as the magnetic energy in the volume V enclosed in the cavity; therefore α is given by

$$\alpha = \frac{\int_{S_f} \tilde{P} dS}{\omega B_0 \frac{\mu_0}{2} \int_V H^2(r) dV} \quad (18)$$

with H being the magnetic field inside the cavity. We focus henceforth on type I superconductors, $\tilde{P} \approx \tilde{P}_1$, to facilitate comparison with experimental data; the corresponding results for α at large κ can be obtained by multiplying our findings by $\sqrt{2/\ln \kappa}$, see section 2.2.

We can separate α into a material-dependent factor and a geometry-dependent one: substituting equations (2) into (18), we write the result as

$$\alpha = \frac{\delta_s(\omega)}{2B_c} G \quad (19)$$

where

$$\delta_s(\omega) = \sqrt{\frac{2\rho_n}{\mu_0 \omega}} \quad (20)$$

is the skin depth and

$$G = \frac{\int_{S_f} H_p^2(r) dS}{\int_V H^2(r) dV} \quad (21)$$

has units of inverse length⁹. The appearance of the skin depth δ_s in equation (19) can of course be traced back to the fact that for type I superconductors the power loss is dominated by the normal-state parts of the surface, see equation (1). The formula (20) for δ_s is valid for the normal skin effect, when $\delta_s \gg \ell$, where ℓ is the mean free path. If this inequality is not satisfied, one should use instead the formula for the *anomalous* skin effect [18]. Up to a numerical factor ~ 1 , the anomalous skin depth is

$$\delta_{s,a}(\omega) = [\delta_s^2(\omega)\ell]^{1/3}; \quad (22)$$

it is independent of the mean free path, since $\rho_n \ell = 3/\nu e^2 v_F$ with ν and v_F being the density of states at the Fermi energy and the Fermi velocity, respectively.

3.1. Measurements of quality factor vs cooling field

To quantitatively test the theory described above, we outline here measurements of the quality factor of two cavities cooled

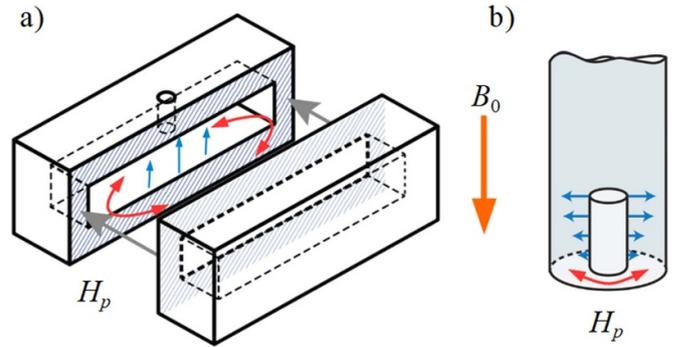


Figure 2. Schematic representation of the (a) rectangular and (b) coaxial cavities. The vertical orange arrows give the direction of the cooling field B_0 . The straight blue arrows represent the electric field of the measured mode and the red curved ones the magnetic field H_p . The relevant surfaces S_f with trapped flux are in (a) the top and bottom ones inside the cavity and in (b) the bottom ring between the end of the coaxial cylinder and the cavity wall (at the top of the coaxial cylinder, the field H_p is negligible).

in the presence of a magnetic field B_0 , as reported in [19]. Two cavities of different shapes were fabricated by machining holes into blocks of high purity (4N) aluminum. One cavity is rectangular in shape, see diagram in figure 2(a), and consists of two halves joined by a seam. The cooling field was applied parallel to the seam, so that normal domains can form without crossing it; this was done to minimize possible field-dependent losses at the seam. For the same reason, the quality factor of the TE_{101} mode with frequency ~ 9.7 GHz was measured; the measurement technique was described in [20]. The second cavity was a $\lambda/4$ coaxial cavity, figure 2(b), similar to those of references [21, 22], but with a higher resonant frequency ~ 9.4 GHz. The cooling field was applied normal to the bottom circular surface, which is therefore the only one that contributes to the trapped-flux dissipation; qualitatively similar results were obtained for fields perpendicular to the cavity axis.

The cavities were cooled down to 30 mK inside a mumetal can to shield them from ambient magnetic fields. Starting from temperature above T_c , different cooling fields were generated by Helmholtz coils placed inside the can and the fields were calibrated by measuring with a fluxgate magnetometer at room temperature for different applied coil currents. To measure cavity performance with different trapped fields, the refrigerator was warmed to approximately 1.5 K, and a current through the coil was applied until the samples cooled to millikelvin temperatures. We observed no significant change in cavity dissipation when either the fields were applied when well below T_c , nor when the magnet was turned off at low temperature.

We show in figure 3 the results of the measurements for the coaxial cavity (circles) and the rectangular one (squares). The lines are best linear fits with intercepts corresponding to zero-field quality factors $Q_c = 7 \times 10^7$ and $Q_r = 2.2 \times 10^7$, and experimental slopes $\alpha_{c,e} = 0.0020 \text{ T}^{-1}$ and $\alpha_{r,e} = 0.0034 \text{ T}^{-1}$ for coaxial and rectangular cavity, respectively. The data display linear behavior down to less

⁹ To avoid confusion, we note that the geometry factor introduced here is not the same used in the accelerator community, G_{acc} . However, if all surfaces contribute to loss by trapped flux, they are related as $G_{\text{acc}} = \pi Z_0/2\tilde{G}$, where Z_0 is the vacuum impedance and the dimensionless factor \tilde{G} is defined in equation (23).

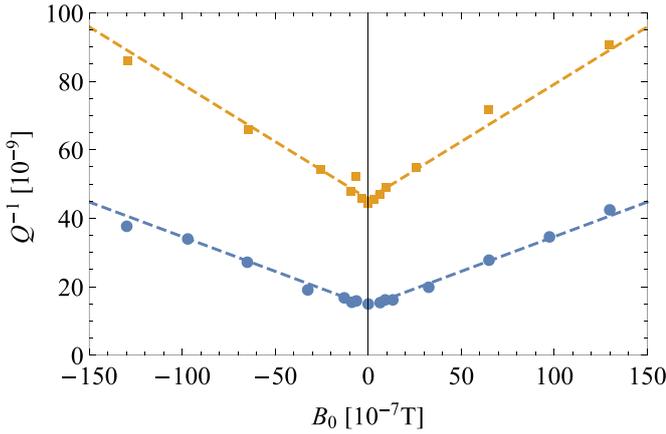


Figure 3. Inverse quality factor vs cooling field. Blue circles: measured quality factor for the coaxial cavity; orange squares: same for the rectangular cavity. Dashed lines are best linear fits to the experimental data.

than 5 mG, indicating that the ambient field is smaller than that. Both slopes agree with an order-of-magnitude estimate from equation (19), as we now show: first, the critical field of aluminum is $B_c \simeq 0.01$ T [23]. The skin depth at low temperature can be estimated from the residual resistivity, which for 4N aluminum is of order $\rho_n \sim 10^{-10} \Omega \cdot \text{m}$ [24]; substituting this value and $\omega/2\pi = 10$ GHz into equation (20) gives $\delta_s \sim 50$ nm. However, this value is small compared to the mean free path $\ell = 3/\rho_n \nu e^2 v_F \sim 4 \mu\text{m}$, where we used $\nu = 1.5 \times 10^{47} \text{Jm}^{-3}$ and $v_F = 2 \times 10^6 \text{m s}^{-1}$. Therefore, we use instead equation (22) to find $\delta_{s,a} \simeq 0.2 \mu\text{m}$. Finally, the geometry factor G is, for low-lying modes, of order of the inverse of the cavity size; the latter is $\sim c/\omega \sim 1$ cm. Substituting these values into equation (19) we get $\alpha \sim 10^{-3} \text{T}^{-1}$, which agrees in order of magnitude with the values extracted from the experiments.

For a more accurate comparison between theory and experiment, we now improve our estimates for the geometry factor. To that end, we find it convenient to introduce a dimensionless geometry factor \tilde{G} defined as

$$\tilde{G} = \frac{\pi c}{2\omega} G. \quad (23)$$

For the coaxial cavity we find $\tilde{G}_c = 2$, and for the rectangular cavity $\tilde{G}_r = 1/b\sqrt{1/a^2 + 1/d^2}$, where b is length in the electric field direction, a and d in the perpendicular directions, see appendix C. In experiment we have $b \approx 5$ mm, $a \approx 17.8$ mm, and $d \approx 31.3$ mm; therefore we estimate $\tilde{G}_r \simeq 3.1$. From the dimensionless \tilde{G} we obtain $G_c^{-1} \sim 0.40$ cm and $G_r^{-1} \sim 0.25$ cm, implying $\alpha_{c,t} \sim 0.0025 \text{T}^{-1}$ and $\alpha_{r,t} \sim 0.0040 \text{T}^{-1}$. The agreement of the two estimates with the respective experimental results is fairly good, given that the anomalous skin depth, equation (22), is defined only up to a numerical factor of order unity.

4. Summary and discussion

When cooled in the presence of a magnetic field, superconductors can trap flux in the form of vortices in type II

superconductors, or normal domains (tubes, laminae) in a type I material. The motion of these normal regions is responsible for dc dissipation. At low temperatures (when the quasiparticle density is exponentially suppressed), and at higher frequencies rendering pinning ineffective, the dominant contribution to the ac absorption may come from two mechanisms: deformation of the superconducting/normal state interfaces and direct absorption at the surfaces of the normal regions exposed to ac fields. In this work, we have reviewed and extended the analysis of these mechanisms to include both type I and type II superconductors; in particular, for type I we study the deformation of the S/N interface in section 2.1. While the deformation of vortex lines is the dominant effect in type II superconductors (at intermediate frequencies [17]), the direct absorption is dominant in type I superconductors, as discussed in section 2.2.

We considered the dependence of the quality factor of a superconducting cavity on the cooling field in section 3. Focusing on type I superconductors, we presented the experimental data for aluminum cavities of two shapes, rectangular and coaxial. The measured reduction of the quality factor associated with an incrementally increasing cooling field is in a good agreement with our theoretical calculation based on independent estimates of material parameters. A further test of the theory could come from the measurement of the cavity frequency shift $\delta f = f(B_0) - f(0)$ vs field. Indeed, using the relation $1/Q + 2i\delta f/f(0) \propto R_s + iX_s$ [20], where $f(0)$ is the zero-field frequency and X_s is the imaginary part of the surface impedance, and since in the normal state the real and imaginary parts are related by $R_s/X_s = -1$ [13], we find $\delta f/f = -1/2Q(B_0)$, with $Q(B_0)$ of equation (17)¹⁰. With our findings, we can answer an important question for applications: what is the maximum field B_0^{max} in which one can cool a cavity while maintaining a high quality factor? As an example, let us assume that $Q \sim 10^9$ is targeted in an aluminum cavity; then inverting equation (17) and using $\alpha \sim 3 \times 10^{-3} \text{T}^{-1}$, we estimate $B_0^{\text{max}} \sim 3 \times 10^{-7}$ T (i.e. a few milliGauss). Since with careful shielding fields smaller than this (about 1 mG) can be obtained, dissipation due to the trapped flux does not necessarily limit the quality factor of such Al cavities to the measured $\lesssim 10^9$ values [20, 25]. In fact, taken together, our estimate for B_0^{max} , the observed linear behavior down to few mG, and the finite intercept corresponding to $Q < 10^8$ in figure 3, indicate that our cavities are limited by some other, independent of field dissipation mechanism (such as dielectric losses, two-level systems, or non-equilibrium quasiparticles). Therefore, further improvements in magnetic shielding to reduce the cooling field are not likely to improve the cavity quality factors, even though at 1 mG the flux trapped e.g. at the bottom of the coaxial cavity corresponds to over 10^4 magnetic flux quanta.

¹⁰ The latter expression holds for the normal skin effect; the right-hand side should be multiplied by $\sqrt{3}$ in the case of anomalous skin effect [18]. For the frequency shift to be reliably measured, the change in $1/Q$ with the field should be larger than a factor of ~ 2 , so that the shift exceeds the linewidth. Such a condition was not met in our measurements, see figure 3, but it may be reached in the future by either using cavities with higher zero-field Q , or by exploring a wider field range.

Recently, niobium cavities designed for particle accelerators have been considered also for quantum information applications [26]. Given the room temperature resistivity ($1.5 \times 10^{-7} \Omega\cdot\text{m}$) and residual resistivity ratio (~ 200), using equation (20) we estimate $\delta_s \sim 4 \times 10^{-7} \text{ m}$ at 1.3 GHz. With $B_c \sim 0.2 \text{ T}$ [7] and $G \sim \omega/c \sim 30 \text{ m}^{-1}$, from equation (19) we find $\alpha_{\text{Nb}} \sim 3 \times 10^{-5} \text{ T}^{-1}$, indicating that Nb cavities are much less affected by ambient field than Al ones. We note that, given the weak dependence of the dissipated power on κ discussed in section 2.2, using type-I formulas is adequate for an order-of-magnitude estimate, since $\kappa \sim 0.73 - 1.5$ for Nb [7, 27]; in fact, cavity-grade Nb behaves as a type-II/1 superconductor in which, due to attraction at long distances, vortices form bundles interspersed by Meissner state regions, a state known as intermediate mixed state [27]. Interestingly, cooling protocols under which flux can be expelled have been developed [28]. Without flux expulsion, the quality factor in a cooling field $B_0 = 10^{-6} \text{ T}$ was measured to be about 1.5×10^{10} , in reasonable agreement with the estimate $Q = 1/\alpha_{\text{Nb}} B_0 \sim 3 \times 10^{10}$. Moreover, measurements of the temperature dependence of the quality factors, both before and after heat treatments, confirm the limiting effect of two-level systems in Nb cavities with low-temperature $Q \lesssim 2 \times 10^{10}$ [26], in qualitative agreement with our analysis for Al cavities; after heat treatment and at the optimal temperature ($\sim 1 \text{ K}$) of highest Q , the measured quality factors are within a factor of 2 from the value $1/\alpha_{\text{Nb}} B_0$, where $B_0 = 2 \text{ mG}$. While these results point to the need to further improvements in the material properties and surface treatments for both Nb and Al, our findings establish that, even for Nb, careful shielding (or flux expulsion) during cooling is necessary to achieve record quality factors.

Data availability statement

The data that support the findings of this study are available from the authors upon reasonable request.

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Appendix A. Ac dissipation in type II superconductors

As mentioned in the Introduction, in type II superconductors the pinning of vortices has long been investigated as a way to reduce flux-flow dissipation. Early models treated pinning by introducing, for example, a harmonic confining potential [29]. In such a model, there is a depinning frequency above which pinning is ineffective and the dissipated power saturates to a frequency-independent value proportional to the flux-flow resistivity ρ_f . Following empirical suggestions, ρ_f is expected to be proportional to the normal-state resistivity ρ_n and the ratio between magnetic field B_0 and second critical field B_{c2} ,

$$\rho_f = \rho_n \frac{B_0}{B_{c2}}. \quad (\text{A.1})$$

Theoretical justification of equation (A.1), attributing ρ_f to the losses in the normal cores of moving vortices was given by Bardeen and Stephen, see [30] and references therein.

Below the depinning frequency, the ac dissipated power increases quadratically with the frequency ω . However, in [29], as well as in subsequent refinements aimed at calculating the surface impedance while accounting for vortex creep [31, 32], the role of the vortex line tension was neglected. More recently, a model accounting for both line tension and strong pinning centers predicted not only a quadratic increase with frequency at the lowest frequencies and a saturation at high frequencies, but also an intermediate frequency domain with a $\sqrt{\omega}$ dependence for the dissipated power. We note that in this regime and at higher frequencies there is no overall motion of a vortex (no vortex creep), and the dissipation can be ascribed to the deformation of the vortex line away from its equilibrium position; in the main part of the paper we use the term deformation rather than motion, as it enables us to treat type I and type II superconductors on the same footing.

Here for simplicity we neglect the effect of pinning¹¹, thus dispensing with the low-frequency quadratic asymptote for the dissipated power, and refer the reader to [17] for its treatment. The extension to random, weak pinning centers of different dimensionalities can be found in [36]. We also disregard the exponentially small effect of quasiparticles which are assumed to be at thermal equilibrium with temperature much smaller than the superconducting gap divided by the Boltzmann constant, $T \ll \Delta/k_B$; thus the ac dissipation is dominated by the flux-flow contribution. This contribution is a potential

¹¹ In other words, we assume a frequency large compared to the depinning frequency. Here we note that the value of the depinning frequency depends on the material considered, including the electron mean free path in it, as well as temperature, magnetic field, and sample thickness, see e.g. [33–35]; while a more detailed analysis of the validity of our assumption is beyond the scope of this work, we note that for a 160 nm thick Nb film, the depinning frequency is below 1 GHz [33] and it decreases with increasing thickness. Therefore for cavities, whose walls are typically at least millimeter thick, frequencies of order hundreds of MHz to several GHz (typical for accelerator and quantum information applications) can indeed be considered large.

explanation for the observation that in many experiments with thin-film quantum devices, the internal dissipation is no longer exponentially improving below $\sim 100\text{--}200\text{ mK}$ ¹².

The model we consider is a slightly simplified version of that in [17]; while this appendix does not present new results, it is included here to make the paper self-contained and to make it easy for the reader to compare the type II and type I cases. The model accounts for the viscous motion of a vortex line under the action of the ac field; denoting by $u(z, t)$ the displacement of an infinitesimal vortex element at depth z from its position in the absence of the ac field, the equation of motion for u reads [see equation (3)]

$$\eta \dot{u} = \varepsilon u'' + F e^{-z/\lambda} e^{-i\omega t}. \quad (\text{A.2})$$

Here the parameters η , ε , and F are per unit length of the vortex line. The textbook expressions for these three quantities can be found, e.g., in [16]. Note that u is in general a two-dimensional vector, but here we treat it as a scalar in the direction of the applied force, a direction which is assumed constant in time.

The drag coefficient η originates from dissipation in the normal core of the vortex. The dissipation is caused by the electric field generated by the vortex motion (section 5.5.1 in [16]),

$$\eta = \frac{\Phi_0^2}{2\pi\xi^2 \rho_n}. \quad (\text{A.3})$$

Here ρ_n is the normal-state resistivity and ξ is the coherence length, which gives approximately the radius of the normal core. The line tension

$$\varepsilon = \frac{\Phi_0^2}{4\pi\mu_0 \lambda^2} \ln \kappa \quad (\text{A.4})$$

is given by the free energy per unit length of a static vortex; the term proportional to it in equation (A.2) accounts for the energy cost of elastic deformation of the vortex. The line tension is mainly due to the kinetic energy of the superfluid current around the vortex, see section 5.1.2 in [16]. There is an additional contribution to ε from the vortex core, which is neglected there; we show explicitly in appendix B that this is a good approximation in strongly type II superconductors with Ginzburg-Landau parameter $\kappa = \lambda/\xi \gg 1$. Finally, the magnitude F of the Lorentz force acting on the vortex line is proportional to the magnitude H_p of the parallel to the surface alternating magnetic field of the impinging electromagnetic wave (see section 5.2 in [16]),

$$F = \Phi_0 H_p / \lambda. \quad (\text{A.5})$$

¹² In the case of thin-film devices in the presence of an out-of-plane magnetic field, one can generically expect type II behavior: thin films are usually disordered superconductors with $\ell \ll \xi_0$, where ξ_0 is the coherence length of the clean material. For disordered superconductors the Ginzburg-Landau parameter is approximately given by $\kappa \approx \lambda/\ell$ (see section 4.2.1 in [16]), which is larger than the corresponding ‘clean’ value. Moreover, for thickness d small compared to λ , the length scale λ_\perp that determines the extent of the supercurrent surrounding the vortex core is $\lambda_\perp \approx \lambda^2/d$ (see section 3.11.4 in [16]); this length scale is longer than the bulk value λ , so that using λ_\perp to calculate κ leads to a further increase in its value compared to that for the bulk material.

Interestingly, the force per unit length F is related to that per unit area \tilde{F} , equation (10), by $\tilde{F} = F/2\pi\xi$, as one would expect by geometrical considerations alone. For the drag and surface tension, on the other hand, there are additional dependencies on κ : comparing equation (A.3) to equation (8) and equation (A.4) to equation (6) we find $\tilde{\eta} = \eta/2\pi\xi\kappa^2$ and $\tilde{\varepsilon} = \varepsilon/2\pi\xi \ln \kappa$.

We are interested in calculating the power P_v dissipated by a vortex as it moves and bends under the action of the ac field. To this end, we need to integrate over z the product $F e^{-z/\lambda} \dot{u}$ of the force and velocity. Therefore, we first solve equation (A.2) for u by performing a Fourier transform,

$$u(z, t) = e^{-i\omega t} \int \frac{dk}{2\pi} \tilde{u}(k) e^{ikz}, \quad (\text{A.6})$$

with the boundary condition $u'(0, t) = 0$ corresponding to no surface pinning. We do not present here explicitly the mathematical derivation of the final expression for P_v , as it is a simplified version of that given in [17]. We note, however, that the line tension ε in general depends on k , but that this dependence can be neglected at low frequency, such that $\omega \ll \omega_\lambda = \varepsilon/\eta\lambda^2$ [the dissipated power saturates to a frequency-independent value for $\omega \gtrsim \omega_\lambda$ [17], see also the text after equation (A.9)]. In this regime, the dissipated power P_v is

$$P_v = \frac{1}{2} (\lambda F)^2 \sqrt{\frac{\omega}{2\eta\varepsilon}} \quad (\text{A.7})$$

which, using equations (A.3)–(A.5), agrees with the corresponding result in [17]. We mention in passing that the $\sqrt{\omega}$ frequency dependence of the dissipated power is not unique to the vortex flow mechanism; on its own, it is insufficient to distinguish it, e.g. from the quasiparticle losses at low (effective) temperature $k_B T \ll \omega$.

It is important to note that even at finite frequency ω the dissipation in a type II material is associated with the motion of vortices, rather than with the penetration of the impinging electromagnetic wave into the normal core of a static vortex. The reason is that the skin depth (which is in general longer than the penetration depth in the superconducting state) exceeds greatly the core radius ξ , which makes such penetration impossible.

In section 2.2 we compare the ac dissipation in type I and type II superconductors, which we denote as \tilde{P}_I and \tilde{P}_{II} , respectively. For such a comparison, we define \tilde{P}_I and \tilde{P}_{II} as the dissipated power per unit surface area of a superconductor cooled in a field B_0 . Considering a sample of area S , the number of vortices N_v is given by the ratio of flux to the flux quantum,

$$N_v = \frac{B_0 S}{\Phi_0}. \quad (\text{A.8})$$

Then at intermediate frequencies the dissipated power per unit area \tilde{P}_{II} is

$$\tilde{P}_{II} = \frac{P_v N_v}{S} = \frac{B_0 H_p^2}{B_c} \frac{1}{2} \sqrt{\frac{\mu_0 \omega \rho_n}{\ln \kappa}}. \quad (\text{A.9})$$

For completeness we address next the dissipated power at higher frequencies, $\omega \gtrsim \omega_\lambda$. The power can be estimated by accounting for the flux-flow resistivity equation (A.1) to be responsible for dissipation over a surface layer of depth λ . That yields the surface resistivity $R_s \sim \rho_f/\lambda$; substituting this expression into the central formula in equation (2) gives the correct result up to numerical factors of order unity.

So far we have neglected the direct absorption at the exposed surface of the normal core of the vortex. To estimate this dissipated power \tilde{P}_s , we calculate the normal-state fraction in a sample of area S as $N_v \pi \xi^2 / S = B_0 / 2\kappa B_c$, with N_v of equation (A.8), and using this estimate (instead of $x_n = B_0/B_c$) in equations (1) and (2) we find

$$\tilde{P}_s = \frac{1}{2\kappa} \frac{B_0}{B_c} \frac{H_p^2}{2} \sqrt{\frac{\mu_0 \omega \rho_n}{2}}. \quad (\text{A.10})$$

Note that we are here assuming that penetration of the impinging wave into the vortex core is possible, which likely overestimates \tilde{P}_s for $\kappa \gg 1$. Nonetheless, the power in equation (A.10) is much smaller than that in equation (A.9).

Appendix B. Vortex core contribution to line tension

Here we consider in more detail the line tension ε for vortices in type II superconductors. In section 5.1.2 of [16] the formula in equation (A.4) is obtained by considering the energy of currents and fields *outside* the vortex core in the limit $\kappa \gg 1$. In principle, there is energy associated with the bending of the core, which is neglected there. We now substantiate such approximation for type II superconductors.

We start by considering a flux tube in a type I superconductor; we indicate below how to extend the final result to the bending of a vortex core. We treat the flux tube as a cylinder of radius R_t and we denote with γ the surface energy associated with a domain wall separating a normal region from a superconducting one. Consider a small piece of height dz of the flux tube: when the top of the small piece is displaced perpendicularly to the z direction by a small amount du , the change in energy due to deformation of the surface is

$$\begin{aligned} \Delta E &= \gamma \Delta A \simeq \gamma 2\pi R_t \left(\sqrt{(dz)^2 + (du)^2} - dz \right) \\ &\simeq \gamma 2\pi R_t dz \frac{1}{2} \left(\frac{du}{dz} \right)^2. \end{aligned} \quad (\text{B.1})$$

From this expression, we estimate the bending contribution ε_b to the line tension to be

$$\varepsilon_b = 2\pi\gamma R_t. \quad (\text{B.2})$$

As discussed in section 2.1, the surface energy is [see equation (5)]

$$\gamma = \delta \frac{B_i^2}{2\mu_0} \quad (\text{B.3})$$

with $\delta \sim \xi - \lambda$ and B_i the field in the normal region. The latter is the critical field B_c in a type I material, but may in general differ from it. In fact, we may apply equation (B.2) to a type II superconductor by setting $R_t \approx \xi$ and using for H_i the vortex core field [see equation (5.14b) in [16]],

$$H_i = \frac{\Phi_0}{2\pi\lambda^2} \ln \kappa. \quad (\text{B.4})$$

This yields

$$\varepsilon_b \simeq -2\pi\xi\lambda \frac{\Phi_0^2}{4\pi^2\mu_0\lambda^4} \ln^2 \kappa = -2 \frac{\ln \kappa}{\kappa} \varepsilon \quad (\text{B.5})$$

where in the last formula we use ε of equation (A.4) [that is, the main contribution to the vortex line tension originating from outside the core]. Since $\kappa \gg 1$, we find $|\varepsilon_b| \ll \varepsilon$.

Appendix C. Dimensionless geometry factor

We sketch here the calculation of the dimensionless geometry factor \tilde{G} for the two cases of interest, a coaxial cavity and a rectangular one, see figure 2.

For the coaxial cavity, the magnetic field for the TEM mode in a $\lambda/4$ resonator can be written in cylindrical coordinates $\{\rho, \theta, z\}$ as [37]

$$\bar{H}(\rho, z) = \hat{\theta} H_m \frac{a}{\rho} \frac{1}{\log a/b} \cos \frac{\pi z}{2L} \quad (\text{C.1})$$

where H_m is the maximum value of the magnetic field in the cavity, a is the radius of the inner conductor, b is that of the outer one, and $L = \lambda/4$ is the length of the inner conductor (in this Appendix, λ denotes the wavelength, not the penetration depth). The shorted part of the coaxial cavity is at $z=0$ and the open part at $z=L$. The resonant frequency is $\omega = 2\pi c/\lambda = \pi c/2L$. Integrations of $H^2(\rho, z)$ over the volume of the cavity and of $H^2(\rho, 0)$ over the bottom surface are straightforward and, using the definitions in equations (21) and (23), give $\tilde{G}_c = 2$.

For the TE₁₀₁ mode of a rectangular cavity, if the electric field is pointing in the y direction, the magnetic field has components in the x and z directions [37]. We do not need to know the spatial profile of the field: the cavity volume is in the region $0 < x < a$, $0 < y < b$, $0 < z < d$ and the surfaces with trapped flux are those at $y=0$ and $y=b$. Then from equation (21) one immediately finds $G_r = 2/b$, since the integrals over variables x and z are the same in the numerator and in the denominator. The result for \tilde{G}_r follows from $\omega = c\sqrt{(\pi/a)^2 + (\pi/d)^2}$ [37].

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